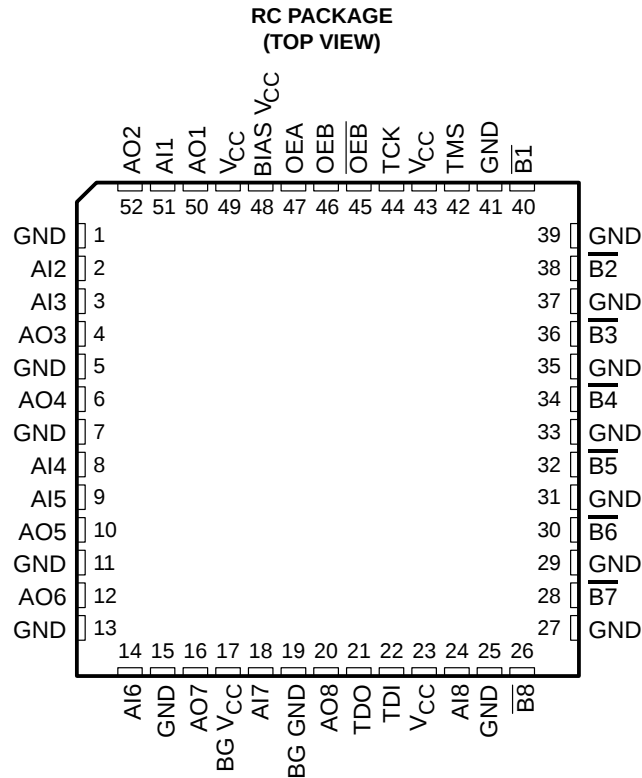


- Compatible With IEEE Std 1194.1-1991 (BTL)
- TTL A Port, Backplane Transceiver Logic (BTL) $\bar{B}$ Port
- Open-Collector $\bar{B}$ -Port Outputs Sink 100 mA
- High-Impedance State During Power Up and Power Down
- BIAS V_{CC} Pin Minimizes Signal Distortion During Live Insertion or Withdrawal
- $\bar{B}$ -Port Biasing Network Preconditions the Connector and PC Trace to the BTL High-Level Voltage



description

The SN74FB2040 is an 8-bit transceiver designed to translate signals between TTL and backplane transceiver logic (BTL) environments.

The $\bar{B}$ port operates at BTL-signal levels. The open-collector $\bar{B}$ ports are specified to sink 100 mA. Two output enables ($\overline{OEB}$ and $\overline{OEB}$) are provided for the $\bar{B}$ outputs. When $\overline{OEB}$ is high and $\overline{OEB}$ is low, the $\bar{B}$ port is active and reflects the inverse of the data present at the A-input pins. When $\overline{OEB}$ is low, $\overline{OEB}$ is high, or V_{CC} is less than 2.1 V, the $\bar{B}$ port is turned off.

The A port operates at TTL-signal levels and has separate input and output pins. The A outputs reflect the inverse of the data at the $\bar{B}$ port when the A-port output enable (OEA) is high. When OEA is low or when V_{CC} is less than 2.1 V, the A outputs are in the high-impedance state.

The pins TMS, TCK, TDI, and TDO are nonfunctional, i.e., not intended for use with the IEEE Std 1149.1 (JTAG) test bus. TMS and TCK are not connected, and TDI is shorted to TDO.

BIAS V_{CC} establishes a voltage between 1.62 V and 2.1 V on the BTL outputs when V_{CC} is not connected.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
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8-BIT TTL/BTL TRANSCEIVER

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ORDERING INFORMATION

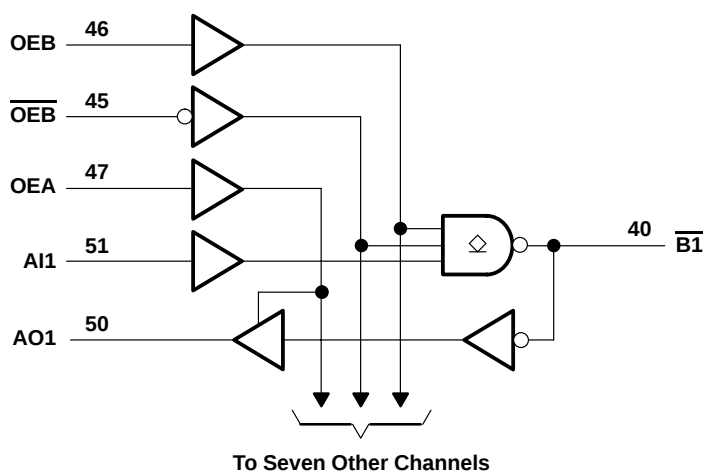
T _A	PACKAGE [†]		ORDERABLE PART NUMBER	TOP-SIDE MARKING
0°C to 70°C	QFP – RC	Tube	SN74FB2040RC	FB2040

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

INPUTS			FUNCTION
OEB	$\overline{\text{OEB}}$	OEA	
L	X	L	Isolation
X	H	L	
L	X	H	$\overline{\text{B}}$ data to AO bus
X	H	H	
H	L	L	$\overline{\text{A}}$ data to B bus
H	L	H	$\overline{\text{A}}$ data to B bus, $\overline{\text{B}}$ data to AO bus

functional block diagram



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC}	–0.5 V to 7 V
Input voltage range, V_I : Except $\bar{B}$ port	–1.2 V to 7 V
$\bar{B}$ port	–1.2 V to 3.5 V
Voltage range applied to any $\bar{B}$ output in the disabled or power-off state, V_O	–0.5 V to 3.5 V
Voltage range applied to any output in the high state, V_O : A port	–0.5 V to V_{CC}
Input clamp current, I_{IK} : Except $\bar{B}$ port	–40 mA
$\bar{B}$ port	–18 mA
Current applied to any single output in the low state, I_O : A port	48 mA
$\bar{B}$ port	200 mA
Package thermal impedance, θ_{JA} (see Note 1)	44°C/W
Storage temperature range, T_{stg}	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
V_{CC} , BIAS V_{CC} , BG V_{CC}	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	$\bar{B}$ port 1.62		2.3	V
		Except $\bar{B}$ port 2			
V_{IL}	Low-level input voltage	$\bar{B}$ port 0.75		1.47	V
		Except $\bar{B}$ port		0.8	
I_{IK}	Input clamp current			–18	mA
I_{OH}	High-level output current	AO port		–3	mA
I_{OL}	Low-level output current	AO port		24	mA
		$\bar{B}$ port		100	
T_A	Operating free-air temperature	0		70	°C

NOTE 2: To ensure proper device operation, all unused inputs must be terminated as follows: A and control inputs to V_{CC} (5 V) or GND, and B inputs to GND only. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

SN74FB2040

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP [†]	MAX	UNIT
V_{IK}	$\overline{B}$ port	$V_{CC} = 4.5\text{ V}$,	$I_I = -18\text{ mA}$			-1.2	V
	Except $\overline{B}$ port	$V_{CC} = 4.5\text{ V}$,	$I_I = -40\text{ mA}$			-0.5	
V_{OH}	AO port	$V_{CC} = 4.5\text{ V}$,	$I_{OH} = -3\text{ mA}$	2.5	3.3		V
V_{OL}	AO port	$V_{CC} = 4.5\text{ V}$,	$I_{OL} = 24\text{ mA}$		0.35	0.5	V
	$\overline{B}$ port	$V_{CC} = 4.5\text{ V}$	$I_{OL} = 80\text{ mA}$	0.75		1.1	
			$I_{OL} = 100\text{ mA}$			1.15	
I_I	Except $\overline{B}$ port	$V_{CC} = 5.5\text{ V}$,	$V_I = 5.5\text{ V}$			50	μA
$I_{IH}^{\ddagger}$	Except $\overline{B}$ port	$V_{CC} = 5.5\text{ V}$,	$V_I = 2.7\text{ V}$			50	μA
$I_{IL}^{\ddagger}$	Except $\overline{B}$ port	$V_{CC} = 5.5\text{ V}$,	$V_I = 0.5\text{ V}$			-50	μA
	$\overline{B}$ port	$V_{CC} = 5.5\text{ V}$,	$V_I = 0.75\text{ V}$			-100	
I_{OH}	$\overline{B}$ port	$V_{CC} = 0\text{ to }5.5\text{ V}$,	$V_O = 2.1\text{ V}$			100	μA
I_{OZH}	AO port	$V_{CC} = 5.5\text{ V}$,	$V_O = 2.7\text{ V}$			50	μA
I_{OZL}	AO port	$V_{CC} = 5.5\text{ V}$,	$V_O = 0.5\text{ V}$			-50	μA
I_{OZPU}	A port	$V_{CC} = 0\text{ to }2.1\text{ V}$,	$V_O = 0.5\text{ V to }2.7\text{ V}$			50	μA
I_{OZPD}	A port	$V_{CC} = 2.1\text{ V to }0$,	$V_O = 0.5\text{ V to }2.7\text{ V}$			-50	μA
$I_{OS}^{\S}$	AO port	$V_{CC} = 5.5\text{ V}$,	$V_O = 0$	-30		-180	mA

[†] All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

[‡] For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

[§] Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS		MIN	TYP [†]	MAX	UNIT
I_{CC}	A port to $\overline{B}$ port	$V_{CC} = 5.5\text{ V}$,	$I_O = 0$		40		mA
	$\overline{B}$ port to AO port				70		
C_i	A port	$V_I = V_{CC}\text{ or GND}$			3.5		pF
	Control inputs				3		
C_O	AO port	$V_O = V_{CC}\text{ or GND}$			6		pF
C_{iO}	$\overline{B}$ port per IEEE Std 1194.1-1991	$V_{CC} = 0\text{ to }4.5\text{ V}$				5	pF
		$V_{CC} = 4.5\text{ V to }5.5\text{ V}$				5	

[†] All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

live-insertion specifications over recommended operating free-air temperature range

PARAMETER		TEST CONDITIONS		MIN	MAX	UNIT
I_{CC} (BIAS V_{CC})		$V_{CC} = 0\text{ to }4.5\text{ V}$,	$V_B = 0\text{ to }2\text{ V}$, V_I (BIAS V_{CC}) = 4.5 V to 5.5 V		450	μA
		$V_{CC} = 4.5\text{ to }5.5\text{ V}$,	$V_B = 0\text{ to }2\text{ V}$, V_I (BIAS V_{CC}) = 4.5 V to 5.5 V		10	
V_O	$\overline{B}$ port	$V_{CC} = 0$,	V_I (BIAS V_{CC}) = 5 V	1.62	2.1	V
I_O	$\overline{B}$ port	$V_{CC} = 0$,	$V_B = 1\text{ V}$, V_I (BIAS V_{CC}) = 4.5 V to 5.5 V	-1		μA
		$V_{CC} = 0\text{ to }5.5\text{ V}$,	OEB = 0 to 0.8 V		100	
		$V_{CC} = 0\text{ to }2.2\text{ V}$,	OEB = 0 to 5 V		100	

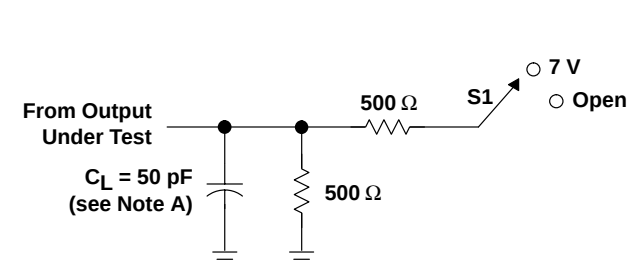


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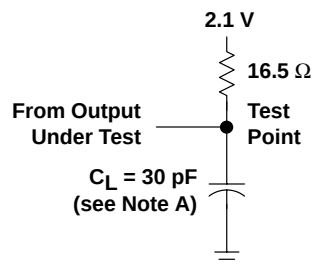
switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, T _A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
t _{PLH}	AI	$\overline{B}$	3.2	4.5	6	2.4	6.5	ns
t _{PHL}			2.8	4.2	5.6	2.7	5.8	
t _{PLH}	$\overline{B}$	AO	2.3	3.8	5.7	1.9	6.2	ns
t _{PHL}			2.3	4.2	5.9	2	8.2	
t _{PLH}	OEB	$\overline{B}$	3.7	5.1	6.7	3	7	ns
t _{PHL}			3.1	4.6	5.9	3	6.1	
t _{PLH}	$\overline{OEB}$	$\overline{B}$	3.6	5.2	6.8	3.3	7	ns
t _{PHL}			2.9	4.4	5.9	2.6	6.1	
t _{PZH}	OEA	AO	2.5	4	5.5	2.1	5.8	ns
t _{PZL}			2.1	3.6	4.8	2	5	
t _{PHZ}	OEA	AO	2.3	4.1	5.9	1.9	6.5	ns
t _{PLZ}			1.6	3.1	4.5	1.4	4.7	
t _{sk(p)}	Skew for any single channel t _{PHL} – t _{PLH} , AI to $\overline{B}$ or $\overline{B}$ to AO		0.5					ns
t _{sk(o)}	Skew between drivers in the same package, AI to $\overline{B}$ or $\overline{B}$ to AO		0.4					ns
t _r	Rise time, 1.3 V to 1.8 V, $\overline{B}$ port		2	2.8	3.8	1.7		ns
t _f	Fall time, 1.8 V to 1.3 V, $\overline{B}$ port		1	1.9	3	1	4.2	ns
t _(pr)	$\overline{B}$ -port input pulse rejection					1	3.4	ns

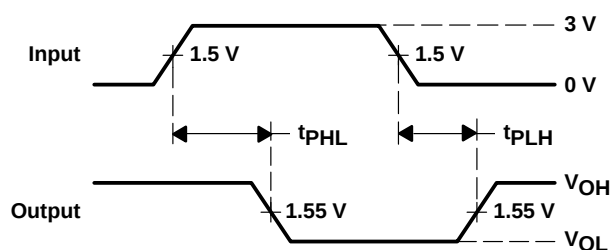
PARAMETER MEASUREMENT INFORMATION



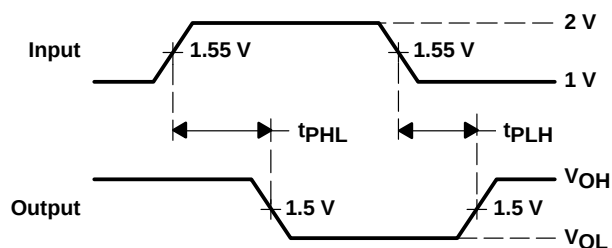
LOAD CIRCUIT FOR A OUTPUTS



LOAD CIRCUIT FOR B OUTPUTS

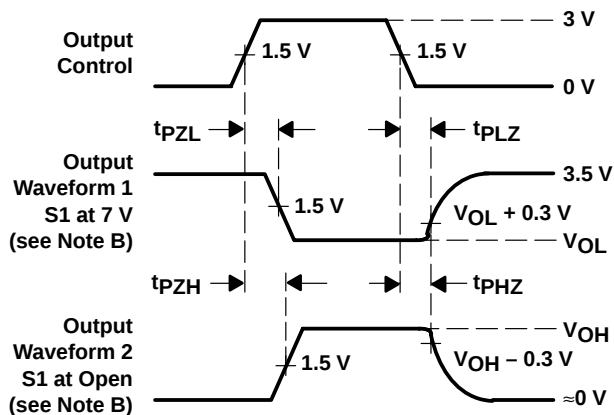


VOLTAGE WAVEFORMS
 PROPAGATION DELAY TIMES (A TO B)



VOLTAGE WAVEFORMS
 PROPAGATION DELAY TIMES (B TO A)

TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	7 V
t_{PHZ}/t_{PZH}	Open



VOLTAGE WAVEFORMS
 ENABLE AND DISABLE TIMES (A PORT)

- NOTES: A. C_L includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: TTL inputs: $PRR \leq 10 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r \leq 2.5 \text{ ns}$, $t_f \leq 2.5 \text{ ns}$; BTL inputs: $PRR \leq 10 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r \leq 2.5 \text{ ns}$, $t_f \leq 2.5 \text{ ns}$.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

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